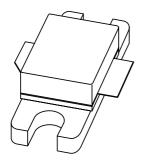
## **DISCRETE SEMICONDUCTORS**

## DATA SHEET



# **BLF2022-30**UHF power LDMOS transistor

Product specification Supersedes data of 2002 Dec 19 2003 Feb 24





## **UHF power LDMOS transistor**

BLF2022-30

#### **FEATURES**

- Typical W-CDMA performance at a supply voltage of 28 V and I<sub>DQ</sub> of 240 mA:
  - Output power = 3.5 W (AV)
  - Gain = 12.9 dB
  - Efficiency = 16.5%
  - ACPR = -45 dBc at 3.84 MHz
  - $d_{im} = -42 dBc$
- · Easy power control
- · Excellent ruggedness
- · High power gain
- · Excellent thermal stability
- Designed for broadband operation (2000 to 2200 MHz)
- · Internally matched for ease of use.

#### **APPLICATIONS**

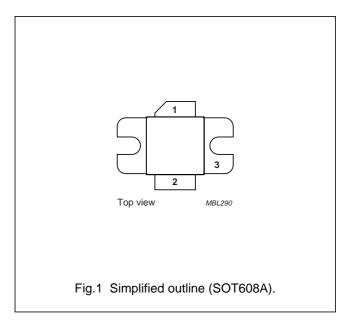
 RF power amplifiers for W-CDMA base stations and multicarrier applications in the 2000 to 2200 MHz frequency range.

## **DESCRIPTION**

30 W LDMOS power transistor for base station applications at frequencies from 2000 to 2200 MHz.

#### **PINNING - SOT608A**

PIN	DESCRIPTION
1	drain
2	gate
3	source, connected to flange



## **QUICK REFERENCE DATA**

Typical RF performance at T<sub>h</sub> = 25 °C in a common source test circuit.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	I <sub>DQ</sub> (mA)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)	d <sub>im</sub> (dBc)	ACLR <sub>5</sub> (dBc)
2-tone, class-AB	$f_1 = 2170; f_2 = 2170.1$	28	240	30 (PEP)	12.6	34.3	-29.5	_
two-carrier W-CDMA test model 1, 64 channels	f <sub>1</sub> = 2155; f <sub>2</sub> = 2165	28	270	3.5 (AV)	12.9	16.5	-42	-45

## **CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

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#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage	_	65	V
$V_{GS}$	gate-source voltage	_	±15	٧
I <sub>D</sub>	DC drain current	_	4.5	Α
T <sub>stg</sub>	storage temperature	-65	+150	°C
Tj	junction temperature	_	200	°C

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-h</sub>	thermal resistance from junction to heatsink	$T_h = 25$ °C; note 1	1.85	K/W

#### **Notes**

1. Thermal resistance is determined under specified RF operating conditions.

## **CHARACTERISTICS**

 $T_i = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	V <sub>GS</sub> = 0; I <sub>D</sub> = 0.7 mA	65	_	_	V
V <sub>GSth</sub>	gate-source threshold voltage	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 70 mA	4.5	_	5.5	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V	_	_	5	μΑ
I <sub>DSX</sub>	on-state drain current	$V_{GS} = V_{GSth} + 9 \text{ V}; V_{DS} = 10 \text{ V}$	9	_	_	Α
I <sub>GSS</sub>	gate leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0$	_	_	11	nA
9fs	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 2.5 A	_	2	_	S
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = V_{GSth} + 9 \text{ V}; I_D = 2.5 \text{ A}$	_	0.3	_	Ω
C <sub>rs</sub>	feedback capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	_	1.7	_	pF

## **APPLICATION INFORMATION**

RF performance in a common source class-AB circuit.  $T_h = 25$  °C;  $R_{th j-c} = 1.85$  K/W; unless otherwise specified.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	I <sub>DQ</sub> (mA)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)	d <sub>im</sub> (dBc)
2-tone, class-AB	$f_1 = 2170; f_2 = 2170.1$	28	240	30 (PEP)	>11	>30	≤–25

## Ruggedness in class-AB operation

The BLF2022-30 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS} = 28 \text{ V}$ ;  $I_{DQ} = 240 \text{ mA}$ ;  $P_L = 30 \text{ W}$ ; f = 2170 MHz.

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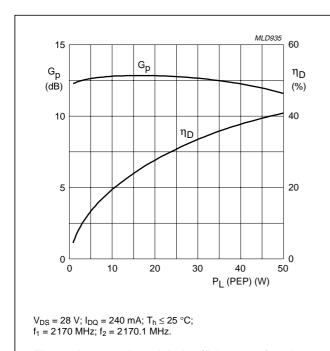


Fig.2 Power gain and drain efficiency as functions of peak envelope load power; typical values.

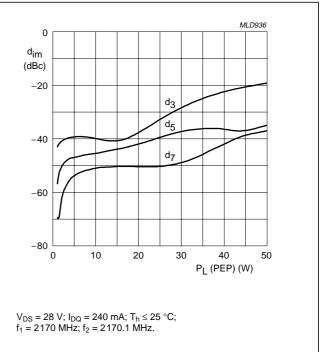
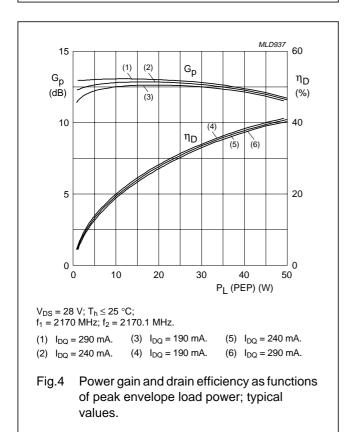
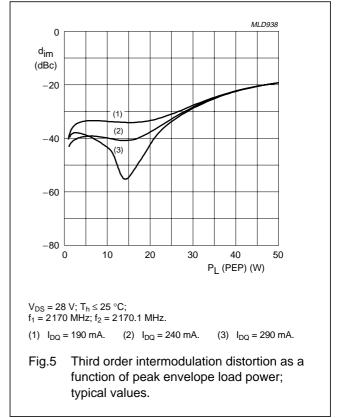


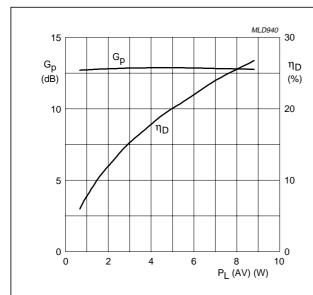
Fig.3 Intermodulation distortion as a function of peak envelope load power; typical values.





## UHF power LDMOS transistor

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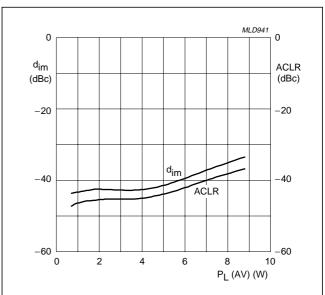


Two-carrier W-CDMA performance.

 $V_{DS}$  = 28 V;  $I_{DQ}$  = 270 mA;  $T_h \le$  25 °C;  $f_1$  = 2170 MHz.

Input signal: 3GPP W-CDMA 64 channels with 66% clipping; peak to average power ratio: 8.5 dB at 0.01% probability on CCDF; channel spacing/bandwidth = 5 MHz / 3.84 MHz.

Fig.6 Power gain and drain efficiency as functions of average load power; typical values.



Two-carrier W-CDMA performance.

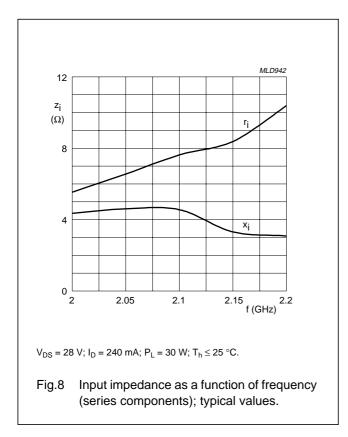
 $V_{DS} = 28 \text{ V; } I_{DQ} = 270 \text{ mA; } T_h \leq 25 \text{ °C; } f_1 = 2155 \text{ MHz; } f_1 = 2165 \text{ MHz;.}$ 

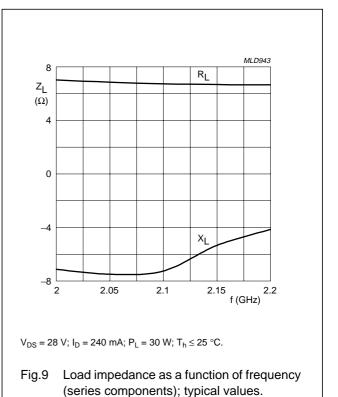
Input signal: 3GPP W-CDMA 64 channels with 66% clipping; peak to average power ratio: 8.5 dB at 0.01% probability on CCDF; channel spacing/bandwidth = 5 MHz / 3.84 MHz.

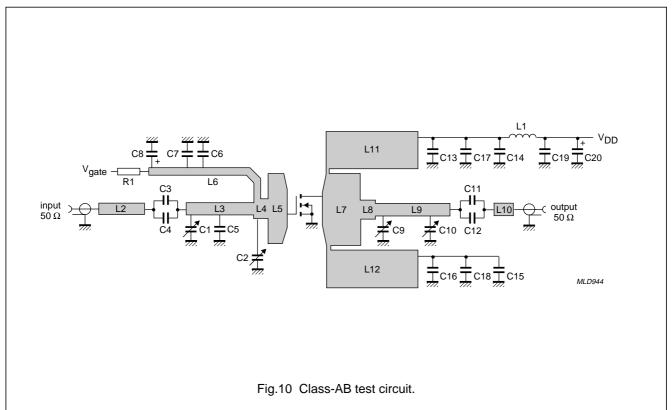
Fig.7 Intermodulation distortion and adjacent channel leakage ratio (ACLR) as functions of average load power; typical values.

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## UHF power LDMOS transistor

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## List of components (See Figs 10 and 11)

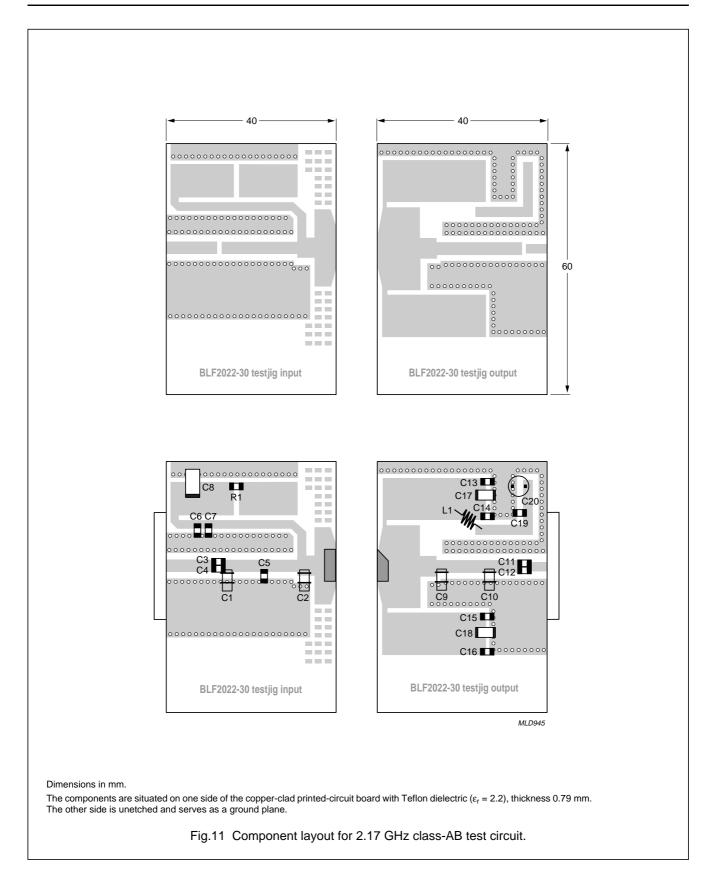
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C2, C9, C10	Tekelec variable capacitor	0.6 to 4.5 pF		
C3, C4, C11, C12	multilayer ceramic chip capacitor; note 1	6.8 pF		
C5	multilayer ceramic chip capacitor; note 1	2.2 pF		
C6, C7, C13, C14, C15, C16	multilayer ceramic chip capacitor; note 1	12 pF		
C8	tantalum capacitor	10 μF		
C17, C18	multilayer ceramic chip capacitor	4.7 μF		TDK C4532X7R1H475M
C19	multilayer ceramic chip capacitor; note 2	1 nF		
C20	electrolytic capacitor	100 μF; 63 V		
L1	handmade		2 loops, dia. 4 mm	
L2	stripline; note 3	50 Ω	12 × 2.4 mm	
L3	stripline; note 3	43 Ω	18 × 3 mm	
L4	stripline; note 3	29 Ω	4 × 5 mm	
L5	stripline; note 3	10 Ω	5 × 18.4 mm	
L6	stripline; note 3	56 Ω	34.4 × 2 mm	
L7	stripline; note 3	9 Ω	10 × 20 mm	
L8	stripline; note 3	29 Ω	4 × 5 mm	
L9	stripline; note 3	41 Ω	20 × 3.2 mm	
L10	stripline; note 3	50 Ω	5 × 2.4 mm	
L11, L12	stripline; note 3	17 Ω	24.5 × 10 mm	

## **Notes**

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. American Technical Ceramics type 100B or capacitor of same quality.
- 3. The striplines are on a double copper-clad printed-circuit board with Teflon dielectric ( $\varepsilon_r = 2.2$ ); thickness 0.79 mm.

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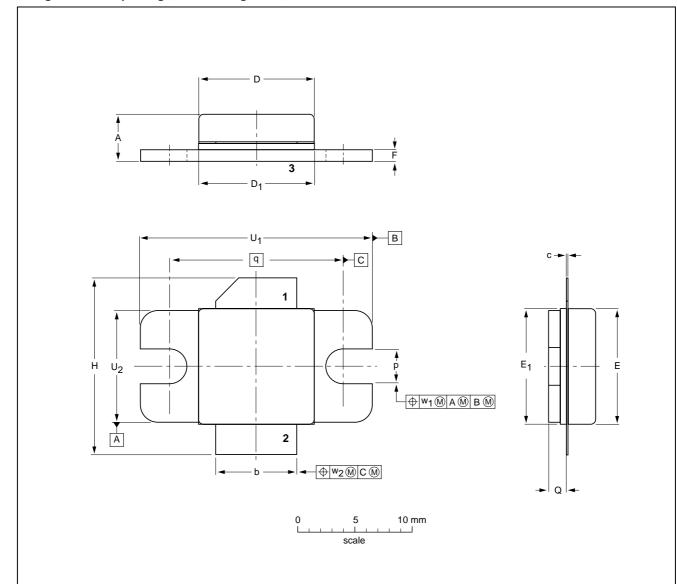
## UHF power LDMOS transistor

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## **PACKAGE OUTLINE**

## Flanged ceramic package; 2 mounting holes; 2 leads

SOT608A



## DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	С	D	D <sub>1</sub>	E	E <sub>1</sub>	F	Н	р	Q	q	U <sub>1</sub>	U <sub>2</sub>	w <sub>1</sub>	w <sub>2</sub>
mm	4.62 3.76	7.24 6.99	0.15 0.10		10.29 10.03				15.75 14.73	3.30 2.92	1.70 1.35	15.24	20.45 20.19		0.25	0.51
inches	0.182 0.148	0.285 0.275			0.405 0.395							0.600		0.390 0.380	0.010	0.020

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT608A						<del>01-02-22</del> 02-02-11

## **UHF** power LDMOS transistor

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NOTES

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